Application/Control No.	Applicant(s)/Patent under Reexamination	
10/749,511	JAHEDI ET AL.	
Examiner	Art Unit	
Len Tran	1725	

SEARCHED				
Class	Subclass	Date	Examiner	
164	138, 267	6/25/2005	LT	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	DATE	EXMR
PALM	6/25/2005	LT
164 (US Patent)	6/25/2005	LT
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